

Notice of References Cited	Application/Control No. 10/561,602		Applicant(s)/Patent Under Reexamination OHMI ET AL.	
	Examiner Robert R. Raevis		Art Unit 2856	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,146,941	09-1992	Statler, William O.	137/8
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	JP 2003-194648, Tokyo Electron Ltd, PATENT ABSTRACT JAPAN, 2 pages, 07/09/2003
*	V	JP 08338546, FUJIKIN:KK, PATENT ABSTRACTS OF JAPAN, 3 pages, 12/24/1996
*	W	JP 10082707, OMI Tadahiro; FUJIKIN:KK, PATENT ABSTRACTS OF JAPAN, 3 pages, *03/31/1998
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.